

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1246	SERIAL NO. 09/517,127		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Scott E. Moore et al			
				FILING DATE March 12, 2000	GROUP Unknown		
U.S. PATENT DOCUMENTS							
Initial	Document Number	Date	Name	Class	Subclass		
JK	AA 5,755,614	05/26/98	Adams et al.				
JK	AB 5,664,990	09/09/97	Adams et al.				
	AC						
	AD						
	AE						
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	AF						
	AG						
	AH						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)						RECEIVED APR -2 2001 TC 3-00 MAIL ROOM	
JK	AI	<a href="http://www.intratechnology.com/haml/sensors.htm">http://www.intratechnology.com/haml/sensors.htm</a> , Intra Technology, Sensors, 03/25/99, 2 pages					
	AJ	<a href="http://www.ftsinc.com/complete/analite/analite.htm">http://www.ftsinc.com/complete/analite/analite.htm</a> , FTS, Analite-SDI Turbidity Sensor, 03/25/99, 1 page					
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JK	AT	<a href="http://www.impactmag.com/O_automat/10970064.htm">http://www.impactmag.com/O_automat/10970064.htm</a> , ABB Instrumentation, The Stockroom, Photodiode Sensor, 1999, 1 page					
EXAMINER <i>JK</i>			DATE CONSIDERED <i>04/20/01</i>				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



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Form PTO-2449

ATTY. DOCKET NO.  
MI22-1246SERIAL NO.  
09/517,127APPLICANT  
Scott E. Moore et al.FILING DATE  
March 12, 2000GROUP  
Unknown

## U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA						
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	AC						
	AD						
	AE						

## FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation
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*04/20/01*

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	AD						
	AE						
FOREIGN PATENT DOCUMENTS							
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	AH						
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<i>TR</i>	AJ	<a href="http://www.intratechnology.com/html/sensors.htm">http://www.intratechnology.com/html/sensors.htm</a> , Intra Technology, Sensor, 03/25/99, 2 pages					
	AJ	<a href="http://www.ftsinc.com/complete/analite/analite.htm">http://www.ftsinc.com/complete/analite/analite.htm</a> , FTS, Analite-SDI Turbidity Sensor, 03/25/99, 1 page					
	AK	<a href="http://www.customsensors.com/optimax.htm">http://www.customsensors.com/optimax.htm</a> , Custom Sensors & Technology, OptiMax 6000 Series Process Photometric Analyzers, 03/25/99, 2 pages					
	AL	<a href="http://www.reflectronics.com/reflectronics_inc_contents.htm">http://www.reflectronics.com/reflectronics_inc_contents.htm</a> , Reflectronics, Inc., Fiber Optic Backscatter Sensor, 03/25/99, 1 page					
	AM	<a href="http://www.honeywell.com/sensing/prodinfo/turbidity/technical/turbidity.st">http://www.honeywell.com/sensing/prodinfo/turbidity/technical/turbidity.st</a> , Gary O'Brien, Honeywell, Turbidity Sensor for Electromechanical Dishwasher Control 1998-1999, 11 pages					
<i>TR</i>	AT	<a href="http://www.impomag.com/O_auroma/10970064.htm">http://www.impomag.com/O_auroma/10970064.htm</a> , ABB Instrumentation, The Stockroom, Photodiode Sensor, 1999, 1 page					
EXAMINER <i>TR</i>				DATE CONSIDERED <i>04/20/01</i>			
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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Scott E. Moore et al.				
				FILING DATE March 12, 2000	GROUP 3723			
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*Examiner Initial	Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate	
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	AB 6,066,030	5/23/00	Uzoh					
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FOREIGN PATENT DOCUMENTS								
	Document Number	Date	Country		Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
	AL							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
AM								
AN								
AO								
EXAMINER <i>J. V. Eley</i>	DATE CONSIDERED <i>04/20/01</i>							
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